Notice of References Cited Application/Control No. 10/049,548 Examiner Thong Q. Nguyen Applicant(s)/Patent Under Reexamination MITZKUS ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,262,837	07-2001	Nagano et al.	359/368
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

		Document Number	Date			
*		Country Code-Number-Kind Code	MM-YYYY	Country	Name	Classification
	N					
	0					
	Р			NON	7	
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Olympus Microscopy Resource Center: Specialized Microscopy Techniques — Fluorescence Microscopy, pages 1-20.
	٧	LIS > Administrative Code > 12 VAC 5 -480-8500. Therapeutic X-ray systems of less than one MeV, pages 1-6.
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.